TOSHIBA Digital Integrated Circuit Silicon Monolithic

# TC7WPN3125FK, TC7WPN3125FC

#### Low Voltage/Low Power 2-Bit Dual Supply Bus Buffer

The TC7WPN3125 is a dual supply, advanced high-speed CMOS 2-bit dual supply voltage interface bus buffer fabricated with silicon gate CMOS technology.

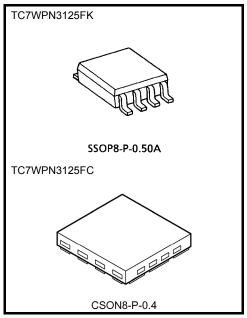
It is also designed with over voltage tolerant inputs and outputs up to  $3.6\ V.$ 

Designed for use as an interface between a 1.2-V, 1.5-V, 1.8-V, or 2.5-V bus and a 1.8-V, 2.5-V or 3.6-V bus in mixed 1.2-V, 1.5-V, 1.8-V or 2.5-V/1.8-V, 2.5-V or 3.6-V supply systems.

The A-input interfaces with the 1.2-V, 1.5-V, 1.8-V or 2.5-V bus, the B-output with the 1.8-V, 2.5-V, 3.3-V bus.

The enable input  $(\overline{OE})$  can be used to disable the device so that the signal lines are effectively isolated.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.



Weight:

SSOP8-P-0.50A: 0.01 g (typ.) CSON8-P-0.4: 0.002 g (typ.)

#### **Features**

- Level converter for interfacing 1.2-V to 1.8-V, 1.2-V to 2.5-V, 1.2-V to 3.3-V, 1.5-V to 2.5-V, 1.5-V to 3.3-V, 1.8-V to 2.5-V, 1.8-V to 3.3-V or 2.5 V to 3.3-V system.
- High-speed operation :  $t_{pd}$  = 13.7 ns (max) ( $V_{CCA}$  = 2.5 ± 0.2 V,  $V_{CCB}$  = 3.3 ± 0.3 V)

 $t_{pd} = 14.8 \text{ ns (max)} (V_{CCA} = 1.8 \pm 0.15 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$ 

 $t_{pd} = 16.0 \text{ ns (max)} (V_{CCA} = 1.5 \pm 0.1 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$ 

 $t_{pd} = 29 \text{ ns (max)} (V_{CCA} = 1.2 \pm 0.1 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$ 

 $t_{pd} = 18.5 \text{ ns (max)} (V_{CCA} = 1.8 \pm 0.15 \text{ V}, V_{CCB} = 2.5 \pm 0.2 \text{ V})$ 

 $t_{pd} = 19.7 \text{ ns (max)} (V_{CCA} = 1.5 \pm 0.15 \text{ V}, V_{CCB} = 2.5 \pm 0.2 \text{ V})$ 

 $t_{pd} = 33 \text{ ns (max) (V}_{CCA} = 1.2 \pm 0.15 \text{ V}, V_{CCB} = 2.5 \pm 0.2 \text{ V})$ 

 $t_{pd}$  = 43 ns (max) (V<sub>CCA</sub> = 1.2 ± 0.1 V, V<sub>CCB</sub> = 1.8 ± 0.15 V)

- Output current :  $IOH/IOL = \pm 3 \text{ mA (min) (VCC} = 3.0 \text{ V)}$ 
  - $IOH/IOL = \pm 2mA \text{ (min) (VCC} = 2.3 \text{ V)}$

 $I_{OH}/I_{OL} = \pm 0.5 \text{ mA (min) (V}_{CC} = 1.65 \text{ V})$ 

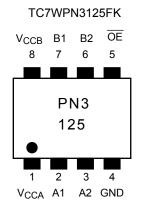
- Latch-up performance: -300 mA
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$

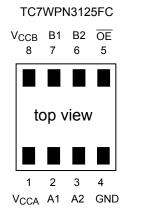
Human body model  $\geq \pm 2000 \text{ V}$ 

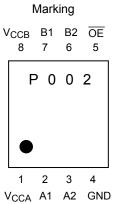
- Ultra-small package: CSON8(CST8), SSOP8(US8)
- Low current consumption: Using the new circuit significantly reduces current consumption when  $\overline{OE}$  = "H". Suitable for battery-driven applications such as PDAs and cellular phones.
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs.

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

## Pin Assignment (top view)







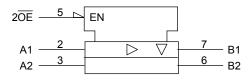
#### **Truth Table**

Inputs		Output
ŌĒ	A1, A2	B1, B2
L	L	L
L	Н	Н
Н	Х	Z

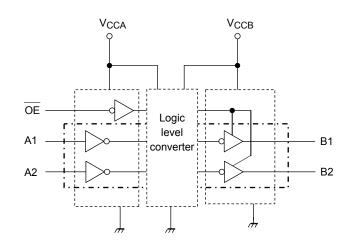
X: Don't care

Z: High impedance

## **IEC Logic Symbol**



## **Block Diagram**





#### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage (Note	VCCA	-0.5 to 4.6	V	
Tower supply voltage (Note	V <sub>CCB</sub>	-0.5 to 4.6	v	
DC input voltage (An, $\overline{\text{OE}}$ )	V <sub>IN</sub>	-0.5 to 4.6	V	
DC output voltage	V <sub>OUT</sub>	-0.5 to 4.6 (Note 3)	V	
(Bn)	VOU1	-0.5 to V <sub>CCB</sub> + 0.5 (Note 4)	V	
Input diode current	lık	-50	mA	
Output diode current	lok	±50 (Note 5)	mA	
DC output current	I <sub>OUTB</sub>	±6	mA	
DC V <sub>CC</sub> /ground current per supply p	I <sub>CCA</sub>	±25	mA	
DC VCC/ground current per supply p	I <sub>CCB</sub>	±50	ША	
Power dissipation	PD	150	mW	
Storage temperature	T <sub>stg</sub>	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Don't supply a voltage to  $V_{CCB}$  pin when  $V_{CCA}$  is in the OFF state.

Note 3: Output in OFF state

Note 4: High or Low stats. IOUT absolute maximum rating must be observed.

Note 5:  $V_{OUT} < GND, V_{OUT} > V_{CC}$ 

### **Operating Ranges (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	V <sub>CCA</sub>	1.1 to 2.7	V
(Note 2	V <sub>CCB</sub>	1.65 to 3.6	V
Input voltage (An, $\overline{\sf OE}$ )	V <sub>IN</sub>	0 to 3.6	V
Output voltage	Voutb	0 to 3.6 (Note 3)	<b>V</b>
(Bn)	VOOTB	0 to V <sub>CCB</sub> (Note 4)	V
Output current		±3 (Note 5)	
(Bn)	loutb	±2 (Note 6)	mA
(Bii)		±0.5 (Note 7)	
Operating temperature	T <sub>opr</sub>	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V<sub>CC</sub> or GND.

3

Note 2: Don't use in  $V_{CCA} > V_{CCB}$ 

Note 3: Output in OFF state

Note 4: High or low state

Note 5:  $V_{CCB} = 3.0 \text{ to } 3.6 \text{ V}$ 

Note 6:  $V_{CCB} = 2.3 \text{ to } 2.7 \text{ V}$ 

Note 7:  $V_{CCB} = 1.65 \text{ to } 1.95 \text{ V}$ 

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CCA} = 2.5$  V,  $V_{CCB} = 3.0$  V



## **Electrical Characteristics**

# DC Characteristics (1.1 V $\leq$ V\_{CCA} $\leq$ 2.7 V , 1.65 V $\leq$ V\_{CCB} $\leq$ 3.6 V)

Characteristics	Current ed	Took	Canditian	V 00	V 00	Ta = -4	0~85°C	l limit
Characteristics	Symbol	Test Condition		V <sub>CCA</sub> (V)	V <sub>CCB</sub> (V)	Min	Max	Unit
			1.1≦V <sub>CCA</sub> <1.4	1.65 to 3.6	0.65 × V <sub>CCA</sub>		V	
H-level input voltage	V <sub>IHA</sub>	V <sub>IN</sub>		1.4≦V <sub>CCA</sub> <1.65	1.65 to 3.6	0.65 × V <sub>CCA</sub>	١	V
				1.65≦V <sub>CCA</sub> <2.3	2.3 to 3.6	0.65 × V <sub>CCA</sub>	_	V
				2.3≦V <sub>CCA</sub> ≦2.7	2.7 to 3.6	1.6	_	V
				1.1≦V <sub>CCA</sub> <1.4	1.65 to 3.6	_	0.30 × V <sub>CCA</sub>	V
L-level input voltage	$V_{ILA}$	V <sub>IN</sub>		1.4≦V <sub>CCA</sub> <1.65	1.65 to 3.6	_	0.30 × V <sub>CCA</sub>	V
				1.65≦V <sub>CCA</sub> <2.3	2.3 to 3.6	_	0.35 × V <sub>CCA</sub>	V
				2.3≦V <sub>CCA</sub> ≦2.7	2.7 to 3.6		0.7	V
			I <sub>OHB</sub> = -100 μA	1.1 to 1.65	1.65 to 3.6	V <sub>CCB</sub> - 0.2	_	V
H-level output voltage	V <sub>OHB</sub> A <sub>n</sub> =	VORB / VII VIII	$I_{OHB} = -0.5mA$	1.1 to 1.4	1.65	1.25	_	
			$I_{OHB} = -2 \text{ mA}$	1.1 to 2.3	2.3	1.7	_	
			$I_{OHB} = -3 \text{ mA}$	1.1 to 3.0	3.0	2.2		
			$I_{OLB} = 100 \mu A$	1.1 to 1.65	1.65 to 3.6	_	0.2	V
L lovel output voltage	\/	Δ \/	$I_{OLB} = 0.5 \text{ mA}$	1.1 to 1.4	1.65	_	0.3	
L-level output voltage	$V_{OLB}$	$A_n = V_{IL}$	I <sub>OLB</sub> = 2 mA	1.1 to 2.3	2.3	_	0.6	
			I <sub>OLB</sub> = 3 mA	1.1 to 3.0	3.0	_	0.55	
3-state output OFF state current	I <sub>OZB</sub>	$A_n = V_{IHA} \text{ or } V_{IHA}$ $B_n = 0 \sim 3.6 \text{ V}$	V <sub>ILA</sub>	1.1 to 2.7	1.65 to 3.6	_	±2.0	μА
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V	,	1.1 to 2.7	1.65 to 3.6	_	±1.0	μΑ
	I <sub>OFF1</sub>	V <sub>IN</sub> , B <sub>n</sub> = 0~3	.6 V	0	0	_	2.0	
Power-off leakage current	I <sub>OFF2</sub>	$\overline{OE} = V_{CCA}$		1.1 to 2.7	0	_	2.0	μΑ
	I <sub>OFF3</sub>	┥		1.1 to 2.7	OPEN	_	2.0	
	ICCA	V <sub>IN</sub> = V <sub>CCA</sub> or GND		1.1 to 2.7	1.65 to 3.6	_	2.0	
	I <sub>CCB</sub> V <sub>IN</sub> = V <sub>CCA</sub> or GND		r GND	1.1 to 2.7	1.65 to 3.6	_	2.0	
Quiescent supply current	ICCA	V <sub>CCA</sub> < V <sub>IN</sub> ≦	3.6 V	1.1 to 2.7	1.65 to 3.6	_	±2.0	μΑ
	I <sub>CCB</sub>	$V_{IN}=V_{CCA}$ $V_{CCB} \leq B_n$	≦ 3.6 V	1.1 to 2.7	1.65 to 3.6	_	±2.0	



## AC Characteristics (Ta = -40 to 85°C, Input: $t_r = t_f = 2.0$ ns)

 $V_{CCA} = 2.5 \pm 0.2$  V,  $V_{CCB} = 3.3 \pm 0.3$  V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	13.7	
3-state output enable time $(\overline{OE} \rightarrow Bn)$	t <sub>pZL</sub> t <sub>pZH</sub>	Figure 1, Figure 3	1.0	16.6	ns
3-state output disable time ( OE → Bn)	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	7.2	
Output to output skew	t <sub>osLH</sub>	(Note)	_	0.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

### $V_{CCA} = 1.8 \pm 0.15 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(\mathrm{An} \to \mathrm{Bn})$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	14.8	
3-state output enable time $(\overline{OE} \rightarrow Bn)$	t <sub>pZL</sub>	Figure 1, Figure 3	1.0	18.9	ns
3-state output disable time ( OE → Bn)	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	8.7	
Output to output skew	t <sub>osLH</sub>	(Note)	_	0.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, \, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

## $V_{CCA} = 1.5 \pm 0.1 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	16.0	
3-state output enable time ( OE → Bn)	t <sub>pZL</sub>	Figure 1, Figure 3	1.0	22.8	ns
3-state output disable time ( OE → Bn)	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	10.2	
Output to output skew	t <sub>osLH</sub>	(Note)	_	1.5	ns

5

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

# $V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 3.3 \pm 0.3$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	29	
3-state output enable time $(\overline{\sf OE} \to {\sf Bn})$	t <sub>pZL</sub>	Figure 1, Figure 3	1.0	63	ns
3-state output disable time ( OE → Bn)	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	23	
Output to output skew	t <sub>osLH</sub>	(Note)	_	1.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

## $V_{CCA} = 1.8 \pm 0.15$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	18.5	
3-state output enable time $(\ \overline{OE} \ \to Bn)$	t <sub>pZL</sub> t <sub>pZH</sub>	Figure 1, Figure 3	1.0	23.6	ns
3-state output disable time $(\overline{OE} \rightarrow Bn)$	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	6.9	
Output to output skew	t <sub>osLH</sub>	(Note)		0.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

## $V_{CCA} = 1.5 \pm 0.1$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	19.7	
3-state output enable time $(\ \overline{OE} \ \to Bn)$	t <sub>pZL</sub> t <sub>pZH</sub>	Figure 1, Figure 3	1.0	26.6	ns
3-state output disable time $(\overline{OE} \to Bn)$	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	8.3	
Output to output skew	t <sub>osLH</sub>	(Note)	_	1.5	ns

6

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, \, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

# $V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	33	
3-state output enable time $(\overline{OE}\to Bn)$	t <sub>pZL</sub> t <sub>pZH</sub>	Figure 1, Figure 3	1.0	66	ns
3-state output disable time ( OE → Bn)	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	20	
Output to output skew	t <sub>osLH</sub>	(Note)		1.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, \, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

 $V_{CCA} = 1.2 \pm 0.1$  V,  $V_{CCB} = 1.8 \pm 0.15$  V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(\text{An} \rightarrow \text{Bn})$	t <sub>pLH</sub>	Figure 1, Figure 2	1.0	43	
3-state output enable time $(\ \overline{OE} \ \to Bn)$	t <sub>pZL</sub>	Figure 1, Figure 3	1.0	78	ns
3-state output disable time $(\overline{OE} \rightarrow Bn)$	t <sub>pLZ</sub>	Figure 1, Figure 3	1.0	20	
Output to output skew	t <sub>osLH</sub>	(Note)	_	1.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, \, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

# **Capacitive Characteristics (Ta = 25°C)**

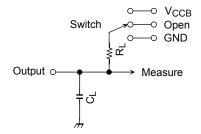
Characteristics	Syn	Symbol	Test Circuit			Тур.	Unit
				V <sub>CCA</sub> (V)	V <sub>CCB</sub> (V)		
Input capacitance		C <sub>IN</sub>	An, $\overline{\text{OE}}$	2.5	3.3	7	pF
Output capacitance		C <sub>OUT</sub>	Bn	2.5	3.3	8	pF
Power dissipation capacitance (Note)		C <sub>PDA</sub>	/OE="L"	2.5	3.3	3	- pF
			/OE="H"	2.5	3.3	0	
		C	/OE="L"	2.5	3.3	13	
	C <sub>PDB</sub>	/OE="H"	2.5	3.3	0		

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 (per bit)$ 

#### **AC Test Circuit**



Parameter	Switch	
t <sub>pLH</sub> , t <sub>pHL</sub>	Open	
t <sub>pLZ</sub> , t <sub>pZL</sub>	V <sub>CCB</sub>	
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND	

Symbol	V <sub>CCB</sub> (output)		
	$\begin{array}{c} 3.3 \pm 0.3 \ \text{V} \\ 2.5 \pm 0.2 \ \text{V} \end{array}$	1.8 ± 0.15 V	
RL	1 kΩ	1 kΩ	
$C_L$	30 pF	30 pF	

Figure 1

8

#### **AC Waveform**

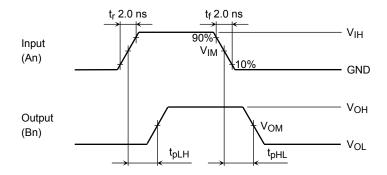


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>

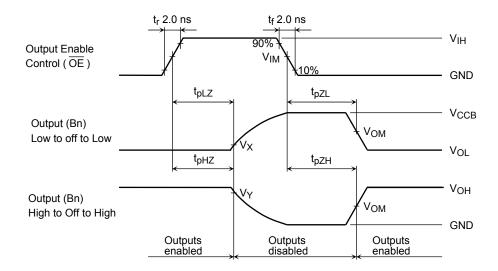
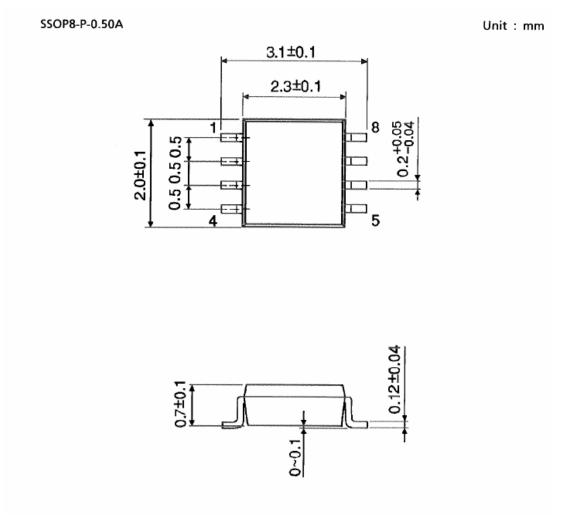


Figure 3  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$ 

		V <sub>CCA</sub> , V <sub>CCB</sub>			
	Symbol	22 - 027	$2.5\pm0.2~\textrm{V}$	$1.5\pm0.1~\text{V}$	
		$3.3 \pm 0.3 \text{ V}$	1.8 ± 0.15 V	$1.2\pm0.1~\textrm{V}$	
Input	V <sub>IH</sub>	-	V <sub>CCA</sub>	$V_{CCA}$	
	V <sub>IM</sub>	-	V <sub>CCA</sub> /2	V <sub>CCA</sub> /2	
Output	V <sub>OM</sub>	V <sub>OH</sub> /2	V <sub>OH</sub> /2	-	
	VX	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	-	
	VY	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	-	

9

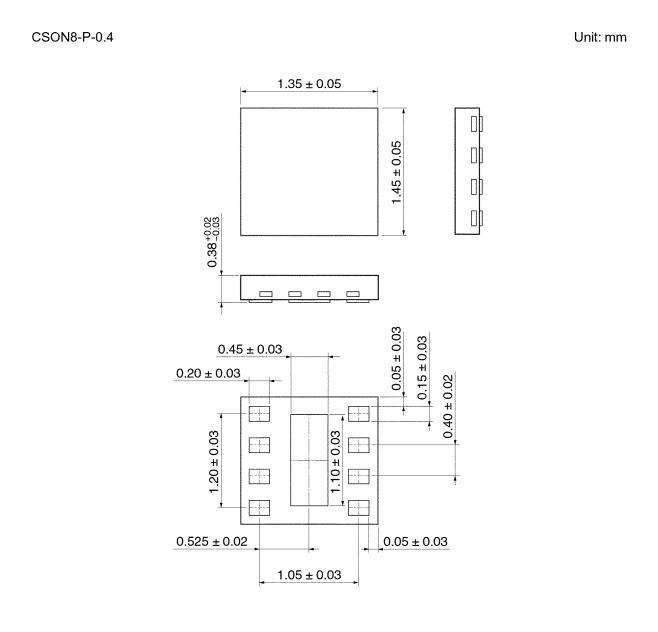
# **Package Dimensions**



weight: 0.01 g (typ.)



# **Package Dimensions**



11

Weight: 0.002 g (typ.)

#### **RESTRICTIONS ON PRODUCT USE**

20070701-EN GENERAL

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS
  compatibility. Please use these products in this document in compliance with all applicable laws and regulations
  that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
  occurring as a result of noncompliance with applicable laws and regulations.

12